

**Search Notes**

Application/Control No.

10/564,416

Examiner

Sara W. Crane

Applicant(s)/Patent under  
Reexamination

ANDO ET AL.

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	103	6/06	SWC
257	103	12/06	SWC
	102		
	101		
438	37		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR